Search	n Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/664,296	HIRANO ET AL.
Examiner	Art Unit
Natalia Figueroa	2651

	SEARCHED		
Class	Subclass	Date	Examiner

ERFERENC	E SEARCH	ED
Subclass	Date	Examiner
		Subclass Date

SEAR (INCLUDING SE	CH NOTES EARCH STRATEC	GY)
	DATE	EXMR
Andrew Sniezek	12/7/2005	5 NFM
Kin Wong	12/7/2005	5 NFM